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INTERNATIONAL STANDARD

NORME INTERNATIONALE

QC 302302

Fixed capacitors for use in electronic equipment - VIEW Part 18-2: Blank detail specification – Fixed aluminium electrolytic surface mount capacitors with non-solid electrolyte – Assessment level EZ

Condensateurs fixes utilisés dans les équipements électroniques – Partie 18-2: Spécification particulière cadre – Condensateurs fixes électrolytiques à l'aluminium pour montage en surface à électrolyte non solide – Niveau d'assurance EZ





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IEC 60384-18-2:2007

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT -

Part 18-2: Blank detail specification – Fixed aluminium electrolytic surface mount capacitors with non-solid electrolyte – Assessment level EZ

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International Standard IEC 60384-18-2 has been prepared by IEC technical committee 40: Capacitors and resistors for electronic equipment.

This second edition cancels and replaces the first edition published in 1993 and constitutes a minor revision related to tables, figures and references.

This bilingual version, published in 2008-07, corresponds to the English version.

The text of this standard is based on the following documents:

CDV	Report on voting
40/1766/CDV	40/1824/RVC

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

The French version of this standard has not been voted upon.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

This International Standard is to be read in conjunction with IEC 60384-18.

The QC number that appears on the front cover of this publication is the specification number in the IEC Quality Assessment System for Electronic Components (IECQ).

The list of all parts of the IEC 60384 series, under the general title *Fixed capacitors for use in electronic equipment*, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

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withdrawn;

• replaced by a revised edition; or <u>IEC 60384-18-2:2007</u>

• amended. https://standards.iteh.ai/catalog/standards/sist/5021ab8d-9926-4701-805cf65760b4a53d/iec-60384-18-2-2007

FIXED CAPACITORS FOR USE IN ELECTRONIC EQUIPMENT –

Part 18-2: Blank detail specification – Fixed aluminium electrolytic surface mount capacitors with non-solid electrolyte – Assessment level EZ

Blank detail specification

A blank detail specification is a supplementary document to the sectional specification and contains requirements for style, layout and minimum content of detail specifications. Detail specifications not complying with these requirements may not be considered as being in accordance with IEC specifications nor shall they so be described.

In the preparation of detail specifications the content of 1.4 of the sectional specification shall be taken into account.

The numbers between square brackets on the first page correspond to the following information, which shall be inserted in the position indicated.

Identification of the detail specification NDARD PREVIEW

- (1) The "International Electrotechnical Commission" (IEC) or the National Standards Organization under whose authority the detail specification is drafted.
- (2) The IEC or National Standards number of the detail specification, date of issue and any further information required by the national system b8d-9926-4701-805c-
- (3) The number and issue number of the IEC or hattonal generic specification.
- (4) The IEC number of the blank detail specification.

Identification of the capacitor

- (5) A short description of the type of capacitor.
- (6) Information on typical construction (when applicable).

NOTE When the capacitor is not designed for use in printed board applications, this is clearly stated in the detail specification in this position.

- (7) Outline drawing with main dimensions which are of importance for interchangeability and/or reference to the national or international documents for outlines. Alternatively, this drawing may be given in an annex to the detail specification.
- (8) Application or group of applications covered and/or assessment level.

NOTE The assessment level(s) to be used in a detail specification are selected from 3.5.4 of the sectional specification. This implies that one blank detail specification may be used in combination with several assessment levels, provided the grouping of the tests does not change.

(9) Reference data on the most important properties, to allow comparison between the various capacitor types.

	(1)	IEC 60384-18-2-XXX	(2)						
		QC 302302-XXX							
ELECTRONIC COMPONENTS OF ASSESSED	(3)	IEC 60384-18-2	(4)						
QUALITY IN ACCORDANCE WITH:		QC 302302							
Outline drawing: (see Table 1)		EIXED ALUMINIUM ELECTROLYTIC SURFACE	(5)						
		MOUNT CAPACITORS WITH NON-SOLID	(0)						
(angle projection)		ELECTROLYTE							
	(7)								
			(6)						
(Other shapes are permitted within the		Assessment level(s): F7	(8)						
dimensions given.)			(0)						
iTeh STAND	AF	D PREVIEW							
<u>(standa</u>	(standards.iteh.ai)								

Information on the availability of components qualified to this detail specification is given in IEC OC 001005.

https://standards.iteh.ai/catalog/standards/sist/5021ab8d-9926-4701-805cf65760b4a53d/iec-60384-18-2-2007

(9)

1 General data

1.1 Recommended method(s) of mounting (to be inserted)

(See 1.4.2 and 4.3 of IEC 60384-18.)

Impedance (if applicable)

Reverse voltage (if required)

Insulation resistance (if applicable)

1.2 Dimensions

Table 1 -	Case	size	reference	and	dimensions

	Dimension(s)										
Case size reference	mm										
	Ø	L	Н	d							
NOTE 1 Whe Table 2, which	n there is no ca then becomes	ase size refere Table 1.	ence, Table 1	may be omitt	ed and the dim	iensions shou	uld be given in				
NOTE 2 The	dimensions sho	ould be given a	as maximum c	limensions o	r as nominal di	mensions wit	h a tolerance.				
1.3 Rating	is and chara	acteristics									
Rated ca	pacitance	ange STA	ANDA	RD PF	(see Table	2)					
Toleranc	e on rated c	apacitance	andard	ls iteh	ai)						
Rated vo	oltage	(su	anuaru		(see Table	2)					
Category	/ voltage (if a	applicable)	IEC 60384-	18-2.2007	(see Table	2)					
Climatic	Climatic categorys://standards.iteh.ai/catalog/standards/sist/5021ab8d-9926-4701-805c-										
Rated te	Rated temperature f65760b4a53d/iec-60384-18-2-2007										
Rated rip	ople current				(see Table	3)					
Tangent	of loss angle	е			(see Table	3)					
Leakage	current										

(see Table 3)

Table 2 – Values of capacitance and of voltage related to case sizes	Table 2 – Values c	of capacitance	and of voltage	related to case size
--	--------------------	----------------	----------------	----------------------

Rated voltage								
Category voltage ^a								
Rated capacitance	Case size	Case size	Case size	Case size				
μF								
^a If different from the rated voltage.								

Table 3 – Tangent of loss angle, impedance and rated ripple current

U _R	С	Tangent of loss angle at °C, Hz	Impedance at °C Hz (if applicable)	Rated ripple current at °C, Hz				
V	μF		Ω	А				
NOTE Instead of the tangent of loss angle (tan δ), the equivalent series resistance ESR may be specified in accordance with 4.5.3.2b) of IEC 60384-18.								

1.4 Normative references

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60384-1, Fixed capacitors for use in electronic equipment – Part 1: Generic specification

IEC 60384-18:2007, Fixed capacitors for use in electronic equipment – Part 18: Sectional specification – Fixed aluminium electrolytic surface mount capacitors with solid (MnO_2) and non-solid electrolyte

IEC 60410:1973, Sampling plans and procedures for inspection by attributes

1.5 Marking

The marking of the capacitor, if applied, and the package shall be in accordance with the requirements of 1.6 of IEC 60384-18.

NOTE The details of the marking of the component and package should be given in full in the detail specification.

1.6 Ordering information

Orders for capacitors covered by this specification shall contain, in clear or in coded form, the following minimum information:

- a) rated capacitance, iTeh STANDARD PREVIEW
- b) tolerance on rated capacitance tandards.iteh.ai)
- c) rated d.c. voltage;
- d) number and issue reference of the detail specification and style reference;
- e) packaging instructions f65760b4a53d/iec-60384-18-2-2007

1057000-4350/100-0058-

1.7 Certified records of released lots

Required/not required.

1.8 Additional information (not for inspection purposes)

1.9 Additional or increased severities or requirements to those specified in the generic and/or sectional specification

NOTE Additions or increased requirements should be specified only when essential.

Table 4 – Other characteristics

This table is to be used for defining characteristics which are additional to, or more severe than, those given in the sectional specification.

2 Inspection requirements

2.1 Procedures

2.1.1 For qualification approval, the procedures shall be in accordance with 3.4 of the sectional specification IEC 60384-18.

2.1.2 For quality conformance inspection, the test schedule (Table 5) includes sampling, periodicity, severities and requirements. The formation of inspection lots is covered by 3.5.1 of the sectional specification.

Subclause number and test ^a	D ^d or ND	Conditions of test ^a	<i>IL</i> ^d	n ^d	c ^d	Performance requirements ^a
Group A inspection (lot-by-lot)				1	1	
Subgroup A1	ND		S-3 ^e	е	0	
4.4 Visual examination						As in 4.4.2 Legible marking and as specified in 1.5 of this specification
4.4 Dimensions (detail) ^b						As specified in Table 1 of this specification
Subgroup A2	ND		S-3 ^e	е	0	
4.5.1 Leakage current		Protective resistance: 1 000 Ω				\leq 0,25 CU μ A/ μ F $ imes$ V or 1 μ A, whichever is greater
4.5.2 Capacitance		Frequency: Hz				Within specified tolerance
4.5.3 Tangent of loss angle (tan δ)		Frequency: Hz				As in 4.5.3
Group B inspection (lot-by-lot)						
Subgroup B1	D		S-3 ^e	е	0	
4.5.4 Impedance (if applicable)	Teh	Frequency: HzARI) PF	E	VI	As specified in Table 3 of this specification
4.7 Solderability	//standar	Test method: solder bath or reflow Solder composition: Flux type for solder bath: non-activated or 8-2 activated alog/standards/sis Solder bath temperatures or reflow temperature	2007 1/5021a 1-18-2-2	ai) 8d-9 2007	926-4	4701-805c-
		profile:				
4.7.2 Final measurements		Visual examination				As in 4.7.2
4.21 Solvent resistance of the marking ^c (if applicable)		Solvent: Solvent temperature: Method 1				Legible marking
		Rubbing material: cotton wool				
		Recovery time:				
 ^a Subclause number of te and Clause 1 of this spetting on dimensional measure on dimensional measure of this may be carried out in this table: <i>IL</i> = inspection level (IE <i>n</i> = sample size <i>c</i> = permissible number <i>p</i> = periodicity in months D = destructive 	ests and ecificatic ed by in ements o on the o C 60410 of non-o	performance requirements on. -production testing if the ma or other mechanisms to avo capacitors mounted on a su 0) conforming items	anufactu anufactu id parts bstrate.	o the irer in exce	sectionstalls	onal specification, IEC 60384-18, s statistical process control (SPC) the limits.

Table 5 – Test schedule for qualification conformance inspection

^e Number to be tested: sample size as directly allotted to the code letter for *IL* in Table 2A of IEC 60410.

Table 5 (continued)

S	ubclause number and test ^ª	D ^d or ND	Conditions of test ^a	Sai and acc	mple s criterio eptabi	ize on of lity ^d	Performance requirements ^a
				р	n	с	
Group	C inspection						
(perio	our C1	П		3	12	0	
4.6	Resistance to		Temperature profile: Recovery: 24 h + 2 h		12		
4.6.3	Final measurements		Visual examination				As in 4.6.3
			Capacitance				} See detail specification
4.20	Component solvent resistance (if applicable)		Solvent: Solvent temperature: Method 2 Recovery:				See detail specification
Subg	oup C2	D		3	12	0	
4.9	Substrate bending test (formerly bond strength of the end face plating)**		Capacitance and impedance (with board in bent position)				See detail specification
	Final measurement		Visual examination				No visible damage and no leakage of electrolyte
Subg	oup C3	Te	h STANDARD	PF	REV	VIE	W
4.3	Mounting		Substrate material:*	toh			
			Visual examination	ten.	.al)		No visible damage and no leakage of electrolyte
	https:/	/standa	Leakage cu <u>rrent60384-18-2:</u> ards iteh ai/catalog/standards/sist	2 <u>007</u> /5021a	h8d-99)26-47	≤ 0,025 CU μA/ μF × V or 1 μA, whichever is greater
	пары	Suile	Capacitance4a53d/iec-60384	-18-2-	2007		$\Delta C/C \le 5$ % of value measured initially
			Tangent of loss angle				As in 4.5.3
			Impedance (if applicable)				As in Table 3
Subg	oup C3.1	D		6	18	0	
4.8	Shear test (formerly adhesion)		Visual examination				No visible damage
4.10.1	Initial measurement		Capacitance (the value obtained) in Subgroup C3 may be used)				
4.10	Rapid change of temperature		T _A = Lower category temperature				
			T _B = Upper category				
			temperature Five cycles Duration t ₄ = 30 min				
			Recovery: 1 h to 2 h				
4.10.3	Final measurements		Visual inspection				No visible damage and no leakage of electrolyte
4.11	Climatic sequence						
4.11.1	Initial measurement		Not required (see 4.10.1)				
4.11.2	Dry heat		Temperature: upper category temperature Duration: 16 h				
The e	xplanation of footnotes t	o table	es is given at the beginning of	Table	5.	, 4h-	datail annaification about indiants
wh ** No su	tich substrate material is t applicable to chip cap bstrates.	s used	in each subgroup. 'n each subgroup. 's, which according to their de	etail sp	pecifica	ation s	hall only be mounted on alumina

Subclause number and test ^a	D ^d or ND	Conditions of test ^a	Sam cr acc	ole size iterion d eptabili	and of ty ^d	Performance requirements ^a	
			р	п	с		
4.11.3 Damp heat, cyclic, Test Db, first cycle							
4.11.4 Cold		Temperature: lower category temperature Duration: 2 h					
4.11.5 Damp heat, cyclic, Test Db, remaining cycles		Recovery: 1 h to 2 h					
4.11.6 Final measurements		Visual examination				No visible damage leakage of electro Legible marking	and no yte
		Leakage current				≤ initial limit	
		Capacitance				$\Delta C/C \le 10$ % of va measured in 4.11.	lue 1
		Tangent of loss angle				\leq 1,2 times initial l	imit
Subgroup C3.2	D		6	9	0		
4.12 Damp heat, steady state	iTe	Recovery: 4 h to 2 h ARI	P R	EVI	EW		
4.12.1 Initial measurement		Capacitance (the value obtained in Sub-group C3S may be used)	teh.a	ai)			
4.12.2 Final measurements		Visual examination ₀₃₈₄₋₁₈₋₂	2007			No visible damage	and no
h	ttps://star	ndards.iteh.ai/catalog/standards/sis	t/5021ab8	8d-9926	4701-80	Leakage of electro	yte
		f65760b4a53d/iec-60384 Leakage current	4-18-2-20	007		≤ initial limit	
		Capacitance				$\Delta C/C \le 20$ % of va measured in 4.12.	lue 1
		Tangent of loss angle				≤ 1.2 times initial	limit
		Impedance				≤ 1,2 times limit i	n Table 3
Subgroup C3.3	D		3	24	0		
4.15 Endurance		Duration: 1 000 h Test temperature: Upper category temperature Applied voltage: V Recovery: 1 h to 2 h					
4.15.1 Initial measurement		Capacitance (the value obtained in Subgroup 3 may be used)					
4.15.3 Final measurements		Visual examination				No visible damage leakage of electro Legible marking	and no yte
		Leakage current				≤ initial limit	
		Capacitance				$\Delta C/C$ compared to measured in 4.15.	values 1
						Rated voltage V	Δ <i>C</i> / <i>C</i> %
						U _R ≤6,3	+25 to -40
						6,3 < <i>U</i> _R ≤ 63	± 30
The explanation of footnotes t	o tables	is given at the beginning of Ta	ble 5.				

Table 5 (continued)